

#### IGBT Chip in NPT-technology

#### **FEATURES:**

- 1200V NPT technology
- 180µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

#### This chip is used for:

 IGBT-Modules BSM150GB120DLC

# Applications: • drives



Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code	
SIGC223T120R2CL	1200V	150A	14.4 x 15.5 mm <sup>2</sup>	sawn on foil	Q67050-A4286- A101	

#### **MECHANICAL PARAMETER:**

Raster size	14.4 x 15.5			
Area total / active	223.2 / 189.9			
Emitter pad size	8x( 3.67x6.77 )			
Gate pad size	1.49 x 1.51			
Thickness	180	μm		
Wafer size	150	mm		
Flat position	90	deg		
Max.possible chips per wafer	54 pcs			
Passivation frontside	Photoimide			
Emitter metalization	3200 nm Al Si 1%			
Collector metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	AI, ≤500μm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	1200	V
DC collector current, limited by T <sub>jmax</sub>	Ic	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	450	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

### STATIC CHARACTERISTICS (tested on chip), $T_{j}$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i arameter		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0V , $I_{C}$ =8 mA	1200			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =150A	1.8	2.2	2.6	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	I <sub>C</sub> =6mA , V <sub>GE</sub> =V <sub>CE</sub>	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			18.2	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			600	nA

#### **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
r arameter			min.	typ.	max.	
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	11	-	nF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	-	-	
Reverse transfer capacitance	Crss	f=1MHz	-	0.7	-	

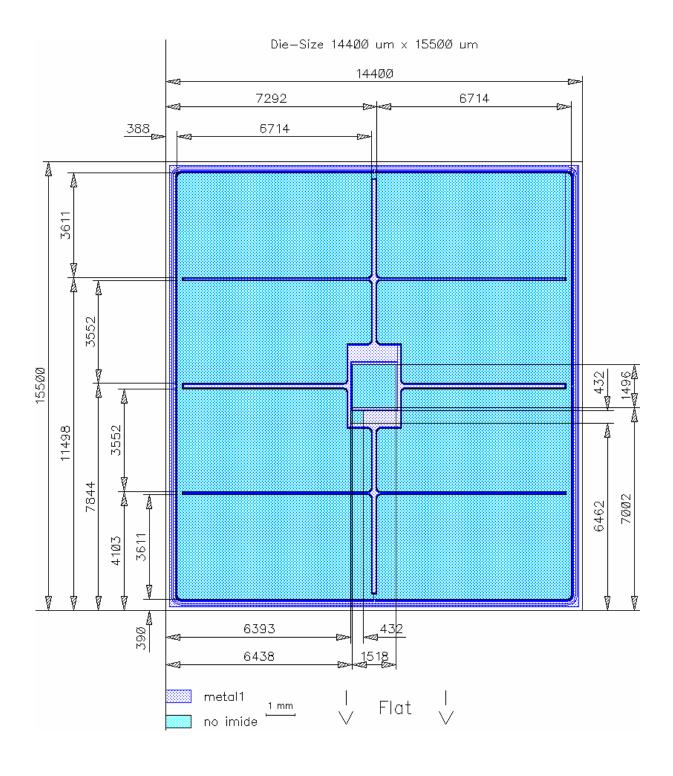
#### SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions 1)	Value			Unit
r arameter			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	T <sub>j</sub> =125°C	-	50	-	ns
Rise time	$t_{r}$	$V_{\rm CC} = 600  \text{V},$ $I_{\rm C} = 150  \text{A}$	-	50	-	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}=\pm 15 \mathrm{V},$ $R_{\rm G}=5.6 \Omega$	-	570	-	
Fall time	$t_{f}$	7.6-0.022	-	40	-	

<sup>&</sup>lt;sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



#### **CHIP DRAWING:**





#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet BSM150GB120DLC Half-Bridge 62mm

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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